

**10/567843**

**IAP20 Rec'd PCT/PTO 10 FEB 2006**

00005.001286

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:	)	
	:	Examiner: Not Yet Assigned
AKIRA MIIKE, ET AL.	)	
	:	Group Art Unit: Not Yet Assigned
Application No.: Not Yet Assigned	)	
	:	
(National Phase of PCT Application No.	)	
PCT/JP2004/011792 filed 11 August 2004)	:	
	:	
Filed: Concurrently herewith	)	
	:	
For: DEVICE FOR MEASUREMENT OF	)	
OBJECT TO BE MEASURED,	:	
APPARATUS FOR	)	
MEASUREMENT AND METHOD	:	
OF MEASUREMENT	)	February 9, 2006

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

PRELIMINARY AMENDMENT

Sir:

Prior to action on the merits, please amend the above-identified application  
as follows: